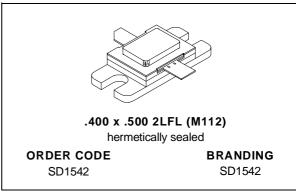


SD1542

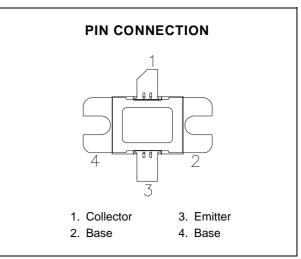
RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- DESIGNED FOR HIGH POWER PULSED IFF AND DME APPLICATIONS
- 600 WATTS (typ.) IFF 1030/1090 MHz
- 550 WATTS (min.) DME 1025 1150 MHz
- 5.6 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INTERNAL INPUT/OUTPUT MATCHED, COMMON BASE CONFIGURATION



DESCRIPTION

The SD1542 is a hermetically sealed, gold metallized, silicon NPN power transistor. The SD1542 is designed for applications requiring high peak power and low duty cycles such as IFF and DME. The SD1542 is packaged in a hermetic metal/ceramic package with internal input/output matching, resulting in improved broadband performance and a low thermal resistance.



ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit
V _{CBO} Collector-Base Voltage		65	V
V _{CES} Collector-Emitter Voltage		65	V
V _{EBO} Emitter-Base Voltage		3.5	V
Ic	Device Current	40	Α
Poiss	Power Dissipation	1350	W
TJ	Junction Temperature	+200	°C
T _{STG}	Storage Temperature	- 65 to +200	°C

THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.06	°C/W

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ELECTRICAL SPECIFICATIONS (T_{case} = 25°C)

STATIC

Symbol	Test Conditions	Value			Unit		
Symbol		rest Conditions		Min. Typ. Ma	Max.		
ВУсво	I _C = 25mA	$I_{E} = 0mA$		65	_		V
BVces	I _C = 50mA	$V_{BE} = 0V$		65	_		V
BV _{EBO}	I _E = 10mA	$I_C = 0mA$		3.5	_	_	V
ICES	V _{CE} = 50V	$I_{E} = 0mA$		_	_	35	mA
hFE	Vce = 5V	$I_C = .25A$		5	_	200	_

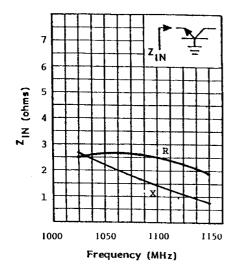
DYNAMIC

Symbol	Test Conditions		Value		Unit
Syllibol	Test Conditions		Тур.	Max.	
Pout	f = 1025 — 1150MHz P _{IN} = 150 W V _{CE} = 50 V	550	_	_	W
G _P	f = 1025 — 1150MHz P _{IN} = 150 W V _{CE} = 50 V	5.6	_	_	dB

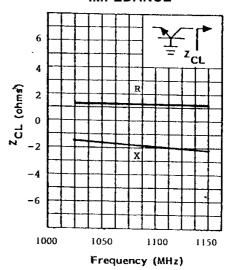
Note: Pulse Width = $10\mu Sec$, Duty Cycle = 1%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE



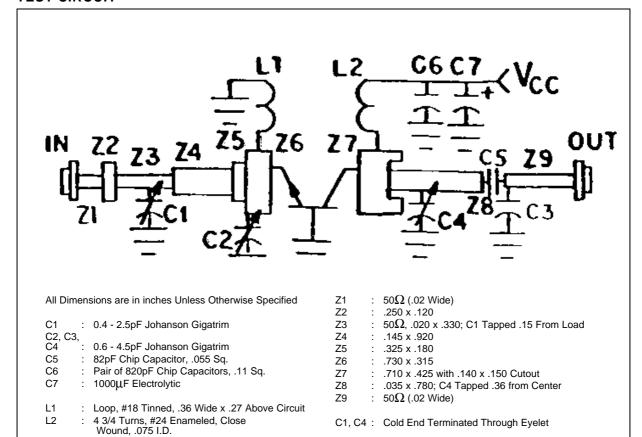
TYPICAL COLLECTOR LOAD IMPEDANCE



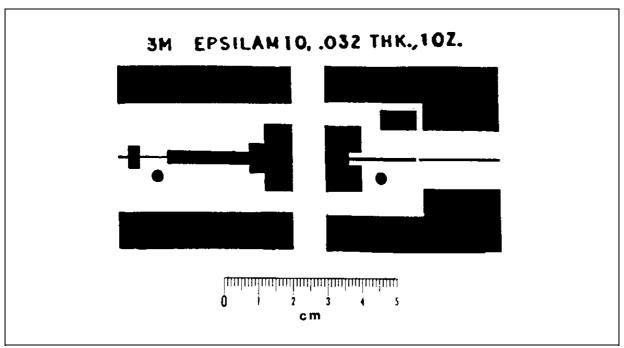
FREQ.	Z_{IN} (Ω)	$Z_{CL}\left(\Omega\right)$
1020 MHz	1.78 + j 3.0	1.33 – j 2.7
1090 MHz	1.57 + j 2.1	1.64 – j 3.4
1150 MHz	1.55 + j 1.4	1.93 – j 4.0

 $P_{IN} = 150 \text{ W}$ $V_{CE} = 50 \text{ V}$

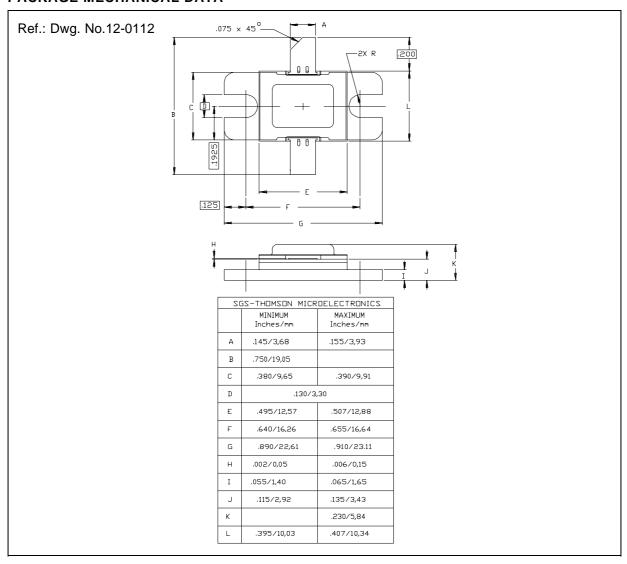
TEST CIRCUIT



PC BOARD LAYOUT



PACKAGE MECHANICAL DATA



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